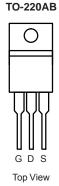


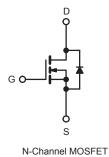
MTP25N06E-VB Datasheet N-Channel 60 V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A) ^a			
60	0.024 at V _{GS} = 10 V	50			
	0.028 at V _{GS} = 4.5 V	40			

FEATURES

- Halogen-free According to IEC 61249-2-21 Definition
- Surface Mount
- Available in Tape and Reel
- Dynamic dV/dt Rating
- Logic-Level Gate Drive
- Fast Switching
- Compliant to RoHS Directive 2002/95/EC





ABSOLUTE MAXIMUM RATINGS ($T_C = 25 \text{ °C}$, unless otherwise noted)						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	60	v	
Gate-Source Voltage			V _{GS}	± 20	V	
Continuous Drain Current ^f	V _{GS} at 10 V	T _C = 25 °C T _C = 100 °C	I _D	50		
Continuous Drain Current	VGS AL TO V	$T_{\rm C} = 100 ^{\circ}{\rm C}$		36	A	
Pulsed Drain Current ^a			I _{DM}	200		
Linear Derating Factor				1.0	W/°C	
Linear Derating Factor (PCB Mount) ^e				0.025		
Single Pulse Avalanche Energy ^b			E _{AS}	400	mJ	
Maximum Power Dissipation	T _C = 25 °C		Р	150	w	
Maximum Power Dissipation (PCB Mount) ^e	T _A = 25 °C		P _D	3.7		
Peak Diode Recovery dV/dt ^c			dV/dt	4.5	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 175	°C	
Soldering Recommendations (Peak Temperature) ^d for 10 s				300 ^d		

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. $V_{DD} = 25 \text{ V}$, starting $T_J = 25 \text{ °C}$, $L = 179 \text{ }\mu\text{H}$, $R_g = 25 \Omega$, $I_{AS} = 51 \text{ A}$ (see fig. 12). c. $I_{SD} \le 51 \text{ A}$, dl/dt $\le 250 \text{ A/}\mu\text{s}$, $V_{DD} \le V_{DS}$, $T_J \le 175 \text{ °C}$.

e. When mounted on 1" square PCB (FR-4 or G-10 material).

f. Current limited by the package, (die current = 51 A).

d. 1.6 mm from case.

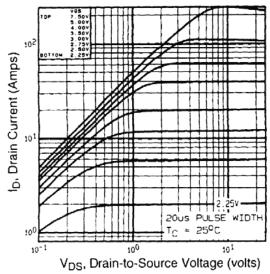


THERMAL RESISTANCE RATI	NGS							
PARAMETER	SYMBOL	ТҮР		MAX.		UNIT		
Maximum Junction-to-Ambient	R _{thJA}	-		62 40				
Maximum Junction-to-Ambient (PCB Mount) ^a	R _{thJA}	-				°C/W		
Maximum Junction-to-Case (Drain)	R _{thJC}	- 1.0			-			
Note a. When mounted on 1" square PCB (FR-4	or G-10 material)). 1						
SPECIFICATIONS (T _J = 25 $^{\circ}$ C, u	Inless otherw	ise noted)						
PARAMETER	SYMBOL	TEST CONDITIONS MIN.			MIN.	TYP.	MAX.	UNIT
Static		-						
Drain-Source Breakdown Voltage	V _{DS}	V _{GS}	= 0, I _D = 25	50 μA	60	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Referenc	e to 25 °C,	I _D = 1 mA	-	0.070	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	- V _{GS} , I _D = 2	250 μA	1.0	-	2.5	
Gate-Source Leakage	I _{GSS}	,	$V_{\rm GS} = \pm 10^{\circ}$	V	-	-	± 100	nA
Zero Gate Voltage Drain Current		$V_{DS} = 60 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			_	-	25	μA
	I _{DSS}	$V_{DS} = 48 V_{c}$	$V_{DS} = 48 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 150 \text{ °C}$			-	250	
		V _{GS} = 10 V		= 21 A ^b	-	0.024	-	Ω
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 4.5 V	5	= 15 A ^b	_	0.028	_	
Forward Transconductance	g _{fs}	÷.÷	= 25 V, I _D =		23	-	-	S
Dynamic	513	20	, ,					
Input Capacitance	C _{iss}				_	190		
Output Capacitance	C _{oss}	V _{GS} = 0 V, V _{DS} = 25 V, f = 1.0 MHz, see fig. 5		_	920	_	pF	
Reverse Transfer Capacitance	C _{rss}			_	170	-		
Total Gate Charge	Q _g	$V_{GS} = 5.0 \text{ V}$ $I_D = 51 \text{ A}, V_{DS} = 48 \text{ V},$			_	-	66	nC
Gate-Source Charge	⊂g Q _{gs}				_	_	12	
Gate-Drain Charge	Q _{gd}		see fig	g. 6 and 13 ^b	_	-	43	
Turn-On Delay Time	t _{d(on)}				_	17	-	
Rise Time	t _r		00.14	F 4 A		230	-	ns
Turn-Off Delay Time			= 30 V, I _D = R _D = 0.56 Ω		_	230	_	
Fall Time	t _{d(off)}	$R_g = 4.6 \Omega$, $R_D = 0.56 \Omega$, see fig. 10^b		_	110		-	
Internal Drain Inductance	t _f	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	_	nH	
Internal Source Inductance	L _S			_	7.5	-		
Drain-Source Body Diode Characteristic	ne la			S				
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	50 ^c	A	
Pulsed Diode Forward Current ^a	I _{SM}			-	-	200		
Body Diode Voltage	V _{SD}	T _J = 25 °C, I _S = 51 A, V _{GS} = 0 V ^b		_	_	2.5	V	
Body Diode Reverse Recovery Time	t _{rr}	$T_{J} = 25 \text{ °C}, I_{F} = 51 \text{ A}, \text{ dl/dt} = 100 \text{ A/}\mu\text{s}^{b}$ Intrinsic turn-on time is negligible (turn		_	130	180	ns	
Body Diode Reverse Recovery Charge	Q _{rr}			_	0.84	1.3	μC	
Forward Turn-On Time				-on is der			<u> </u>	
lotes	t _{on}				5115 001	initiated D	, <u>-</u> 5 and	-0/

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
b. Pulse width ≤ 300 µs; duty cycle ≤ 2 %.
c. Current limited by the package, (Die Current = 51 A).



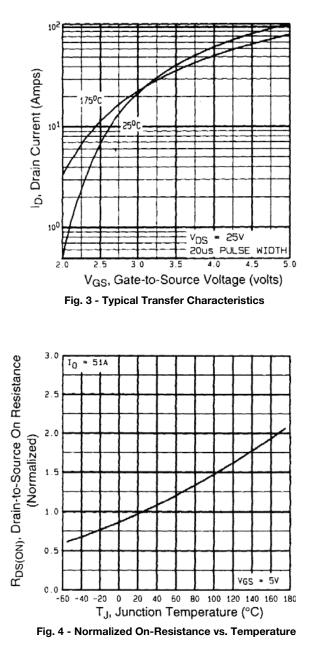


TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)





Fig. 2 - Typical Output Characteristics, T_C = 150 °C





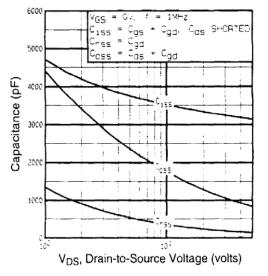


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

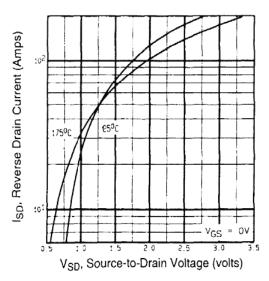
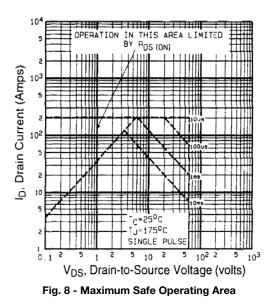


Fig. 7 - Typical Source-Drain Diode Forward Voltage



Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage





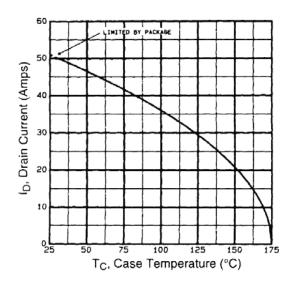


Fig. 9 - Maximum Drain Current vs. Case Temperature

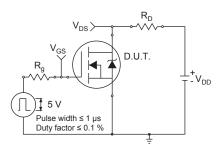


Fig. 10a - Switching Time Test Circuit

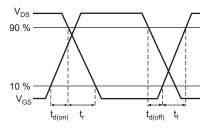
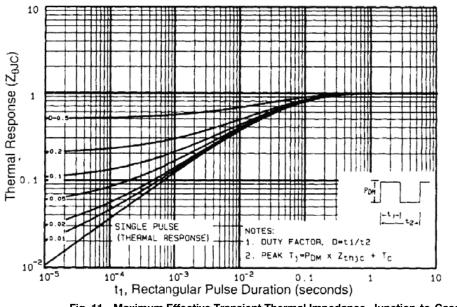


Fig. 10b - Switching Time Waveforms







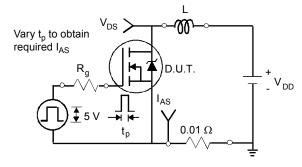


Fig. 12a - Unclamped Inductive Test Circuit

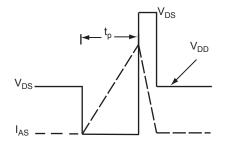


Fig. 12b - Unclamped Inductive Waveforms

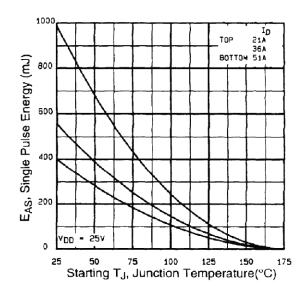


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

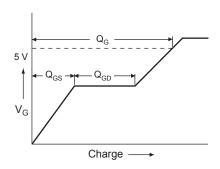


Fig. 13a - Basic Gate Charge Waveform

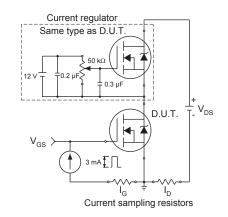
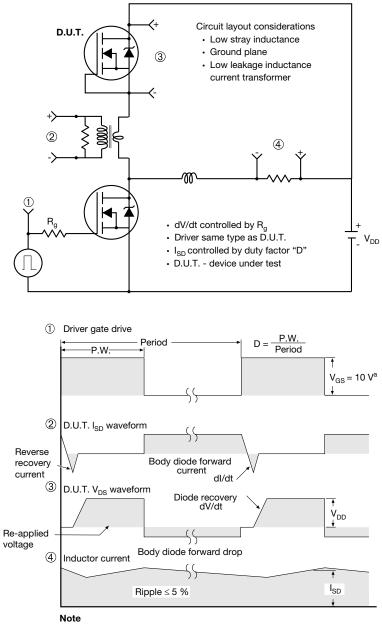


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit

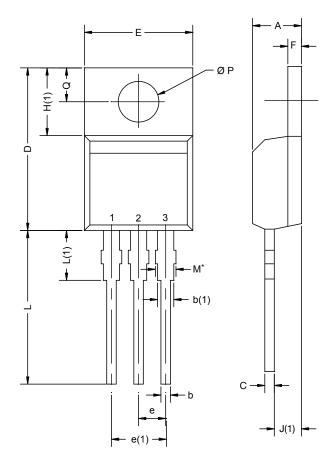


a. V_{GS} = 5 V for logic level devices

Fig. 14 - For N-Channel



TO-220AB



	MILLIN	IETERS	INCHES			
DIM.	MIN.	MAX.	MIN.	MAX.		
А	4.25	4.65	0.167	0.183		
b	0.69	1.01	0.027	0.040		
b(1)	1.20	1.73	0.047	0.068		
С	0.36	0.61	0.014	0.024		
D	14.85	15.49	0.585	0.610		
Е	10.04	10.51	0.395	0.414		
е	2.41	2.67	0.095	0.105		
e(1)	4.88	5.28	0.192	0.208		
F	1.14	1.40	0.045	0.055		
H(1)	6.09	6.48	0.240	0.255		
J(1)	2.41	2.92	0.095	0.115		
L	13.35	14.02	0.526	0.552		
L(1)	3.32	3.82	0.131	0.150		
ØΡ	3.54	3.94	0.139	0.155		
Q	2.60	3.00	0.102	0.118		
	0208-Rev. N,					

Notes

* M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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